

ABSTRACT

There are provided an etching gas and an etching method capable of selectively etching an etching object containing silicon as compared with a non-etching object. The etching gas contains fluorobutene represented by a general formula $C_4H_xF_y$, in which x is 1 or more and 7 or less, y is 1 or more and 7 or less, and $x + y$ is 8. The etching gas contains or does not contain at least one of alkali metals and alkaline earth metals as metal impurities, and the sum of the concentrations of alkali metals and alkaline earth metals when contained is 5000 ppb by mass or less. The etching method includes an etching step of bringing the etching gas into contact with a member to be etched (12) having an etching object and a non-etching object, and selectively etching the etching object as compared with the non-etching object. The etching object contains silicon.

Fig. 1